

Search Notes

Application/Control No.

09/995,378

Examiner

Chris Parry

Applicant(s)/Patent under
Reexamination

OHNO, TOMOYUKI

Art Unit

2614

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 725 | 39-40 | 12/29/2005 | CLP |
| 725 | 43-44 | 1/3/2006 | CLP |
| 725 | 48-49 | 1/4/2006 | CLP |
| 725 | 52 | 1/3/2006 | CLP |
| 725 | 59 | 1/3/2006 | CLP |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|----------|------|
| See attached search history from EAST (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB) | 1/4/2006 | CLP |
| Consulted Scott Beliveau (re: Claim 26). | 1/4/2006 | CLP |
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